

OptiMOS™-5 Power-Transistor





Features

- OptiMOS™ power MOSFET for automotive applications
- N-channel Enhancement mode Normal Level
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested

Quality Features

- Infineon Automotive Quality
- Extended qualification beyond AEC Q101
- · Enhanced testing
- Advanced adhesion against delamination
- · Complementary testing for board level reliability







Туре	Package	Marking
IAUZ40N08S5N100	PG-TSDSON-8	5N08100

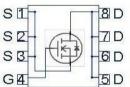
Maximum ratings, at T_i =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continous drain current	I _D	T _C =25°C, V _{GS} =10V ¹⁾	40	А
		T _C =100 °C, V _{GS} =10 V ²⁾	40	
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25°C	160	
Avalanche energy, single pulse ²⁾	E _{AS}	I _D =20 A	75	mJ
Avalanche current, single pulse	I _{AS}	-	32	А
Gate source voltage	V_{GS}	-	±20	V
Power dissipation	P_{tot}	T _C =25 °C	68	W
Operating and storage temperature	$T_{\rm j}$, $T_{\rm stg}$	-	-55 +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	

Product Summary

V _{DS}	80	V
R _{DS(on)}	10	$m\Omega$
I_{D}	40	Α







Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal characteristics ²⁾						
Thermal resistance, junction - case	R_{thJC}	-	-	-	2.2	K/W
Thermal resistance, junction - ambient ³⁾	R _{thJA}		-	38.5	1	

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =1 mA	80	ı	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS},I_{\rm D}=27~\mu{\rm A}$	2.2	3	3.8	
Zero gate voltage drain current	I _{DSS}	$V_{\rm DS} = 80 \text{ V}, V_{\rm GS} = 0 \text{ V}, $ $T_{\rm j} = 25 \text{ °C}$	1	1	1	μA
		$V_{\rm DS}$ =80 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =85 °C ²⁾	ı	ı	100	
Gate-source leakage current	I _{GSS}	$V_{\rm GS}$ =20 V, $V_{\rm DS}$ =0 V	-	ı	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =6 V, I _D =10 A	-	11.6	14.5	mΩ
		V _{GS} =10 V, I _D =20 A	-	8.4	10	
Gate resistance ²⁾	R _G		-	1.2	-	Ω



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics ²⁾						
Input capacitance	Ciss		-	1224	1591	pF
Output capacitance	Coss	V _{GS} =0 V, V _{DS} =40 V, f=1 MHz	-	231	300	
Reverse transfer capacitance	C _{rss}		-	13.5	20	
Turn-on delay time	t _{d(on)}		-	3	-	ns
Rise time	t _r	V _{DD} =40 V, V _{GS} =10 V,	-	1	-	
Turn-off delay time	$t_{d(off)}$	I_{D} =40 A, R_{G} =3.5 Ω	-	7	-	
Fall time	t_{f}]	-	5	-	
Gate Charge Characteristics ²⁾ Gate to source charge	Q _{gs}	V _{DD} =40 V, I _D =20 A, V _{GS} =0 to 10 V	-	5.8	7.5	nC
Gate to drain charge	Q_{gd}		-	4.5	6.8	
Gate charge total	Qg		-	18.6	24.2	
Gate plateau voltage	V _{plateau}		-	4.8	-	V
Reverse Diode						
Diode continous forward current ²⁾	Is	T _25 °C	-	-	40	А
Diode pulse current ²⁾	I _{S,pulse}	- T _C =25 °C	-	-	147	1
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =20 A, T _j =25 °C	-	0.9	1.2	V
Reverse recovery time ²⁾	t _{rr}	V_R =40 V, I_F =40A, di_F/dt =100 A/ μ s	-	37	-	ns
Reverse recovery charge ²⁾	Q _{rr}		-	32	_	nC

Current is limited by bondwire; with an $R_{\text{thJC}} = 2.2 \text{ K/W}$ the chip is able to carry 58A at 25°C.

²⁾ The parameter is not subject to production test - verified by design/chracterization.

³⁾ Device on four layer 2s2p PCB defined in accordance with JEDEC standards (JESD51-5-7). PCB is vertical in still air.

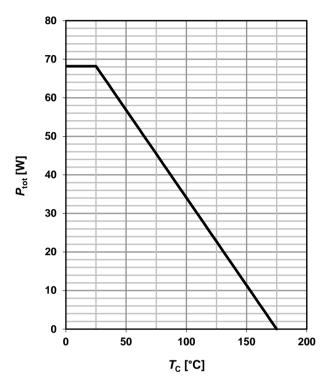


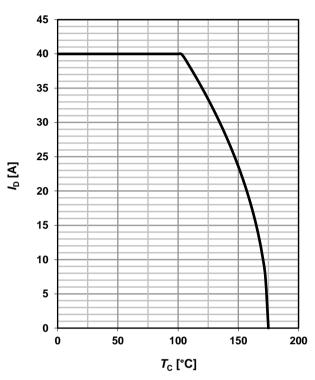
1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} \ge 6 \text{ V}$$

2 Drain current

$$I_D = f(T_C); V_{GS} \ge 6 \text{ V}$$





3 Safe operating area

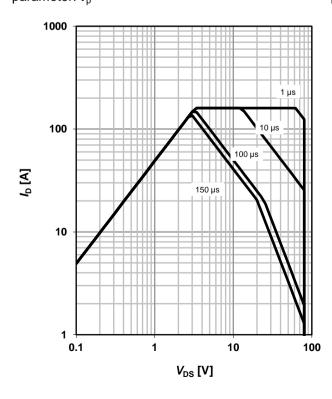
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

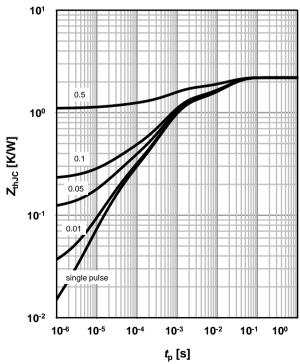
parameter: t_p

4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_{p})$$

parameter: $D=t_p/T$



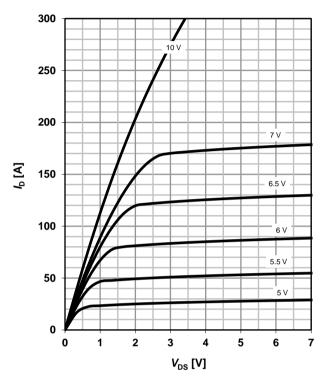




5 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 \text{ °C}$

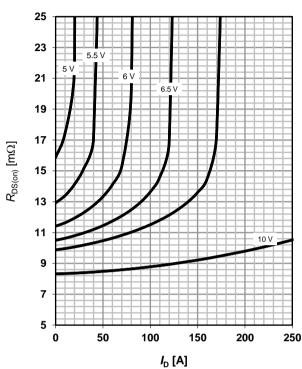
parameter: V_{GS}



6 Typ. drain-source on-state resistance

 $R_{DS(on)} = (I_D); T_j = 25 \text{ °C}$

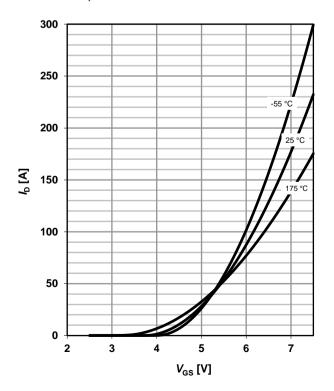
parameter: V_{GS}



7 Typ. transfer characteristics

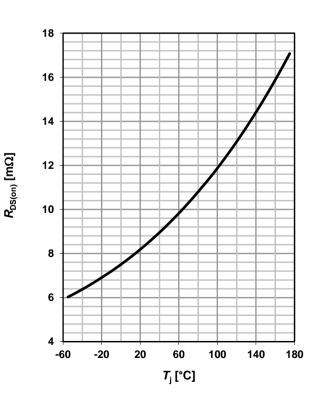
 $I_D = f(V_{GS}); V_{DS} = 6V$

parameter: $T_{\rm j}$



8 Typ. drain-source on-state resistance

$$R_{DS(on)} = f(T_j); I_D = 20 \text{ A}; V_{GS} = 10 \text{ V}$$





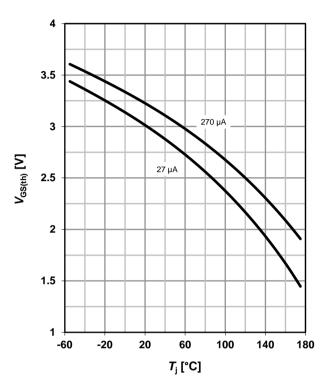
9 Typ. gate threshold voltage

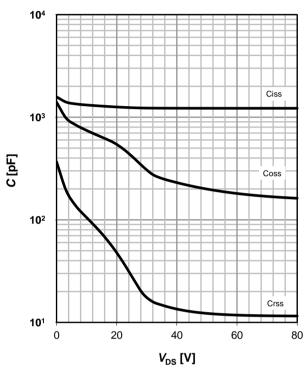
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter: I_D

10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$





11 Typical forward diode characteristicis

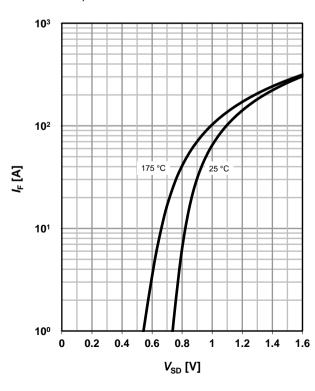
 $IF = f(V_{SD})$

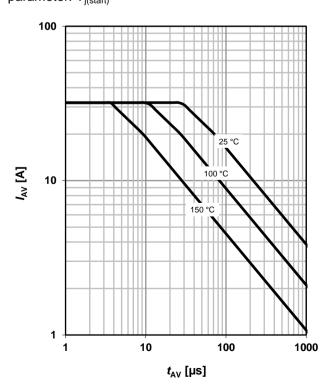
parameter: $T_{\rm j}$

12 Typ. avalanche characteristics

 $I_{AS} = f(t_{AV})$

parameter: T_{j(start)}







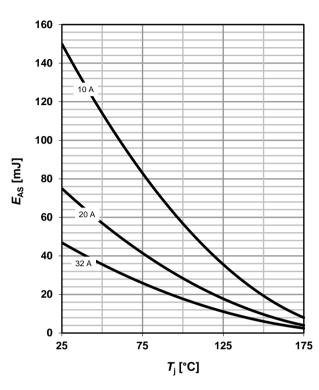
13 Typical avalanche energy

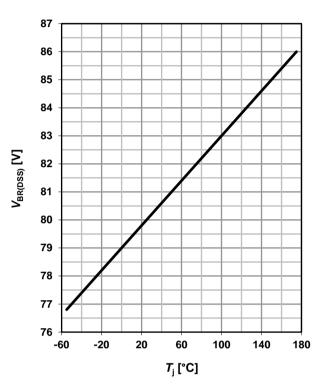
 $E_{AS} = f(T_i)$

parameter: I_D

14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_{D_{typ}} = 1 \text{ mA}$$

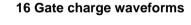


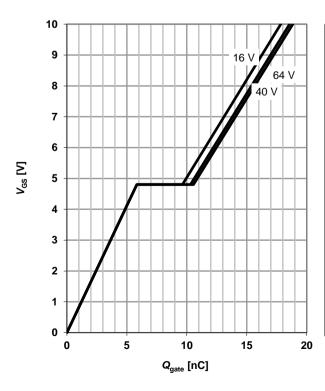


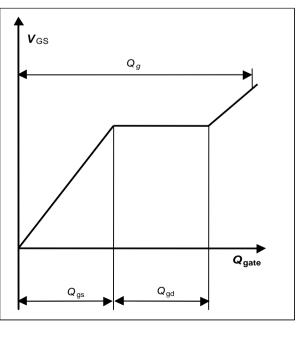
15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 20 A pulsed$

parameter: V_{DD}







0.24

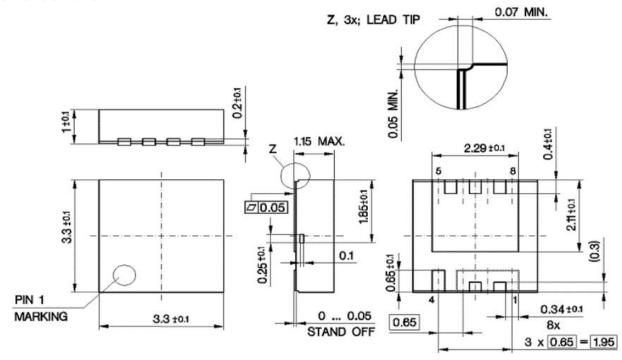
9.0

5

0.24



PG-TSDSON-8: Outline



Footprint 2.29 0.31 0.65 0.34 0.41 0.31 0.65 2.36 1.55 0.35 1.09 1.45 0.45 0.24 0.41 0.34 0.65 0.34

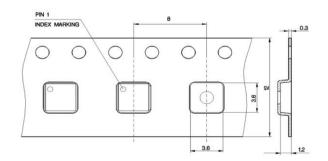
Solder Mask Copper

1.64

Stencil Apertures

Dimensions in mm

Packaging





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